


<b>Search Notes</b>  	<b>Application/Control No.</b>  10080729	<b>Applicant(s)/Patent Under Reexamination</b>  EYER, MARK KENNETH
	<b>Examiner</b>  ALBERT T CHOU	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
370	535, 516	6/14/2008	AC
715	203	6/14/2008	AC

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search - EAST	6/14/2008	AC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner